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# **RF Exposure Evaluation Report**

Product : ESP-12S

Trade mark : N/A

Model/Type reference : ESP-12S

Serial Number : N/A

Report Number : EED32K00061602 FCC ID : 2AHMRESP12S

**Date of Issue** : Apr. 08, 2018

47 CFR Part 1.1307

**Test Standards** : 47 CFR Part 1.1310 KDB 447498 D01v06

TOB THE TOB

Test result : PASS

#### Prepared for:

Shenzhen Ai-Thinker Technology co., LTD. 6/F, Block C2, Huafeng Industrial Park, Hangcheng Road, Baoan district, Shenzhen, China

Prepared by:

Centre Testing International Group Co., Ltd. Hongwei Industrial Zone, Bao'an 70 District, Shenzhen, Guangdong, China

TEL: +86-755-3368 3668 FAX: +86-755-3368 3385

Tested By:

10M- Chen

Tom chen (Test Project)

Reviewed by:

kein Tong

Kevin yang (Reviewer)

Approved by Report Seal

Kevin lan (Project Engineer)

Sheek Luo (Lab supervisor)

Sheek Luo (Lab Supervisor)

Date: Apr. 08, 2018 Check No.:2392184354

Hotline: 400-6788-333 www.cti-cert.com E-mail: info@cti-cert.com Complaint call: 0755-33681700 Complaint E-mail: complaint@cti-cert.com









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# 2 Version

Version No.	Date		Description	
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#### 4 General Information

#### 4.1 Client Information

Applicant:	Shenzhen Ai-Thinker Technology co., LTD.
Address of Applicant:	6/F, Block C2, Huafeng Industrial Park, Hangcheng Road, Baoan district, Shenzhen, China
Manufacturer:	Shenzhen Ai-Thinker Technology co., LTD.
Address of Manufacturer:	6/F, Block C2, Huafeng Industrial Park, Hangcheng Road, Baoan district, Shenzhen, China
Factory:	Shenzhen Ai-Thinker Technology co., LTD.
Address of Factory:	6/F, Block C2, Huafeng Industrial Park, Hangcheng Road, Baoan district, Shenzhen, China

# 4.2 General Description of EUT

Product Name:	ESP-12S	15
Model No.:	ESP-12S	
Trade Mark:	N/A	
EUT Supports Radios application:	Wi-Fi: 802.11 b/g/n(20M) , 2412MHz-2462MHz	
Power Supply:	DC 3.3V	

# 4.3 Product Specification subjective to this standard

Modulation Type:	DSSS, OFDM
Antenna Type:	PCB Antenna
Antenna Gain:	3dBi
Test Voltage:	DC 3.3V and AC 120V/60Hz
	14.09dBm(0.025644mW)*
Conducted Peak Output Power:	The Conducted Peak Output Power data refer to the report EED32K00061601
Sample Received Date:	Mar. 22, 2018
Sample tested Date:	Mar. 22, 2018 to Apr. 02, 2018
The tested sample and the	sample information are provided by the client.

#### 4.4 Test Location

All tests were performed at:

Centre Testing International Group Co., Ltd.

Hongwei Industrial Zone, Bao'an 70 District, Shenzhen, Guangdong, China 518101

Telephone: +86 (0) 755 3368 3668 Fax:+86 (0) 755 3368 3385

No tests were sub-contracted.











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## 4.5 Deviation from Standards

None.





#### 4.6 Abnormalities from Standard Conditions

None.



None.















































































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# 5 RF Exposure Evaluation

## 5.1 RF Exposure Compliance Requirement

#### **5.1.1 Limits**

According to FCC Part1.1310: The criteria listed in the following table shall be used to evaluate the environment impact of human exposure to radio frequency (RF) radiation as specified in part1.1307(b)

TABLE 1—LIMITS FOR MAXIMUM PERMISSIBLE EXPOSURE (MPE)

Frequency range (MHz)	Electric field strength (V/m)	Magnetic field strength (A/m)	Power density (mW/cm²)	Averaging time (minutes)
(A) Lim	its for Occupational	/Controlled Exposure	es	
0.3–3.0	614 1842/f	1.63 4.89/f	*(100) *(900/f²)	6
30–300	61.4	0.163	1.0 f/300	6
1500-100,000			5	6
(B) Limits	for General Populati	on/Uncontrolled Exp	osure	
0.3–1.34	614	1.63	*(100)	30
1.34–30	824/f	2.19/f	*(180/f <sup>2</sup> )	30
30–300	27.5	0.073	0.2	30
300-1500			f/1500	30
1500-100,000			1.0	30

A rough estimation of the expected exposure in power flux density on a given point can be made with the following equation:

$$S = \frac{P \times G}{4 \times \pi \times R^2}$$

Where:

S = power density

P = power input to the antenna

G = numeric gain of the antenna in the direction of interest relative to an isotropic radiator

R= distance to the centre of radiation of the antenna

EIRP = P\*G

The antenna of the product, under normal use condition is at least 20 cm away from the body of the user. Warning statement to the user for keeping at least 20cm separation distance and the prohibition of operating to a person has been printed on the user's manual. Therefore, the S of the device is calculated with R=20cm, and if it is below the limits, then we can conclude the device complies with the rules.

#### 5.1.2 Test Procedure

Software provided by client enabled the EUT to transmit data at lowest, middle and highest channel individually.











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5.1.3 EUT RF Exposure Evaluation

Antenna Gain: 3dBi

Output Power Into Antenna & RF Exposure Evaluation Distance:

Channel	Frequency (MHz)	Max Conducted Peak Output Power(dBm)	Gain (dBi)	EIRP* (dBm)	EIRP (mW)	R (cm)	S (mW/cm <sup>2</sup> )	Limit (mW/cm²)	Result
middle	2437	14.09	3	17.09	51.17	20	0.01	1.0	Pass

Note: Refer to report No. EED32K00061601 for EUT test Max Conducted Peak Output Power value.

































































































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## **PHOTOGRAPHS OF EUT Constructional Details**

Refer to Report No. EED32K00061601 for EUT external and internal photos.

#### \*\*\* End of Report \*\*\*

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